

Search Notes

Application/Control No.

09/886,741

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

2815

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------------------------|-----------|----------|
| 257 | E25.023, 668, 698 & 700 | 6/15/2006 | C.C. |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB; | 6/15/2006 | C.C. |
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